

**Search Notes****Application/Control No.**

10/638,218

**Examiner**

Nam V. Nguyen

**Applicant(s)/Patent under Reexamination**

SINGH, ABHISHEK

**Art Unit**

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	5.2	2/27/2006	NN
340	5.28	2/27/2006	NN
340	5.3+	2/27/2006	NN
340	5.7+	2/27/2006	NN
340	5.8+	2/27/2006	NN
382	115	2/27/2006	NN
382	116	2/27/2006	NN
382	187	2/27/2006	NN
382	124	2/27/2006	NN
235	380	2/27/2006	NN
235	384	2/27/2006	NN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search: USPAT; US-PUB; EPO; JPO and Derwent. (UPDATED SEARCH).	2/27/2006	NN
Consult with Benjamin Lee	6/23/2005	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
SAME AS	ABOVE	2/27/2006	NN